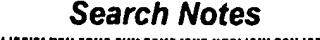


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/609,280	HOWARTH ET AL.
	Examiner	Art Unit
	Betsey M. Hoey	1724

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner